Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/762,246	HANINA ET AL.
Examiner	Art Unit
Hai C. Pham	2861

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	233, 238, 241-245, 256-261	9/22/2006	HP
	231		

TNI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
347	233, 243	9/22/2006	HP
	260		
PGPub t	ext Search	9/22/2006	HP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Text Search	9/22/2006	HP